Power MOSFET 30 V, 90 A, Single N-Channel, SO-8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Par	Parameter			Value	Unit
Drain-to-Source Vo	Drain-to-Source Voltage			30	V
Gate-to-Source Vol	tage		V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	18	Α
Current R _{θJA} (Note 1)		T _A = 85°C		13	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.25	W
Continuous Drain Current R _{0JA}		T _A = 25°C	ID	11	Α
(Note 2)	Steady State	T _A = 85°C		8	
Power Dissipation R _{0JA} (Note 2)	Slate	T _A = 25°C	P _D	0.89	W
Continuous Drain Current R _{0JC}		T _C = 25°C	I _D	90	Α
(Note 1)		T _C = 85°C		65	
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C	P _D	55.6	W
Pulsed Drain Current	$T_A = 25^{\circ}C,$ $t_p = 10 \ \mu s$		I _{DM}	180	Α
Operating Junction a Temperature	Operating Junction and Storage Temperature			–55 to +150	°C
Source Current (Boo	Source Current (Body Diode)			46	Α
Drain to Source DV/DT			dV/dt	6	V/ns
Energy (T _J = 25°C, \	Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 50 V, V_{GS} = 10 V, I_L = 22 A_{pk} , L = 1.0 mH, R_G = 25 Ω)			242	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

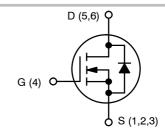
- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.



ON Semiconductor®

http://onsemi.com

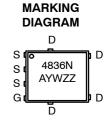
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
	4.0 mΩ @ 10 V	
30 V	6.0 mΩ @ 4.5 V	90 A



N-CHANNEL MOSFET



CASE 488AA STYLE 1



Α = Assembly Location

= Year W = Work Week = Lot Traceability 77

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4836NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4836NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.25	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	55.6	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	140.8	

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				25		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25 °C			1	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)	•						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.0		mV/°0
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V to	I _D = 30 A		2.8	4.0	
		11.5 V	I _D = 15 A		2.8		
		V _{GS} = 4.5 V	I _D = 30 A		4.8	6.0	mΩ
			I _D = 15 A		4.8		
Forward Transconductance	9FS	V _{DS} = 15 V, I	_D = 15 A		24		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C _{ISS}				2677		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 12 V			565		pF
Reverse Transfer Capacitance	C _{RSS}				307		1
Total Gate Charge	Q _{G(TOT)}				20	28	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _I	ns = 15 V:		3.2		
Gate-to-Source Charge	Q _{GS}	I _D = 30	Ä		8.0		
Gate-to-Drain Charge	Q_{GD}				8.0		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V, V _{DS} = 15 V; I _D = 30 A			45		nC
SWITCHING CHARACTERISTICS (Note 6)							•
Turn-On Delay Time	t _{d(ON)}				14		
Rise Time	t _r	VGS = 4.5 V Vr	ne = 15 V.		30		
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			20		ns
Fall Time	t _f				12		
Turn-On Delay Time	t _{d(ON)}				8.0		
Rise Time	t _r	V_{GS} = 11.5 V, V_{DS} = 15 V, I_{D} = 15 A, I_{G} = 3.0 Ω			27		ns
Turn-Off Delay Time	t _{d(OFF)}				31		
Fall Time	t _f				7.0		

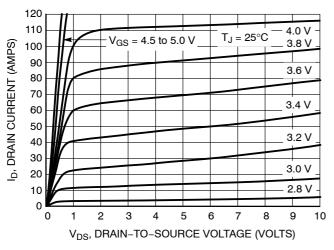
Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

^{5.} Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS								
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.83	1.2		
		$V_{GS} = 0 \text{ V},$ $I_{S} = 30 \text{ A}$	T _J = 125°C		0.7		V	
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 30 A			27.1		ns	
Charge Time	t _a				13.8			
Discharge Time	t _b				13.3			
Reverse Recovery Charge	Q _{RR}				16		nC	
PACKAGE PARASITIC VALUES								
Source Inductance	L _S	T _A = 25°C			0.65		nH	
Drain Inductance	L _D				0.005		nH	
Gate Inductance	L _G				1.84		nH	
Gate Resistance	R_{G}				1.2		Ω	

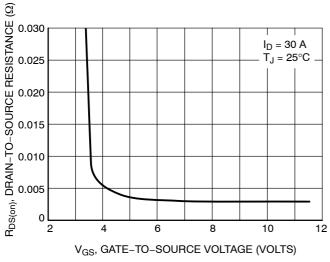
TYPICAL PERFORMANCE CURVES



110 $V_{DS} \ge 10 \text{ V}$ 100 ID, DRAIN CURRENT (AMPS) 90 80 70 60 50 40 $T_J = 25^{\circ}C$ 30 20 $T_J = 125^{\circ}C$ 10 $T_J = -55^{\circ}C$ 0 0 2 5 6 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



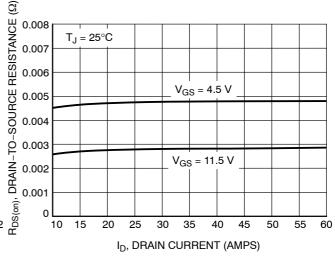
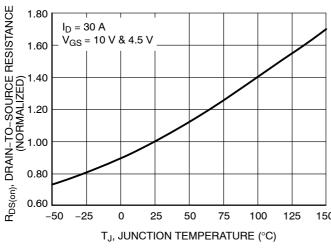


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



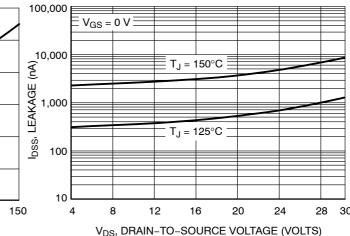
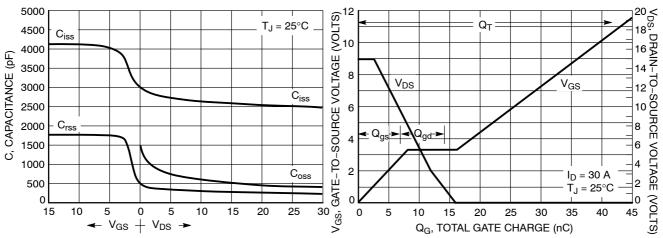


Figure 5. On–Resistance Variation with Temperature

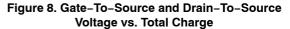
Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation



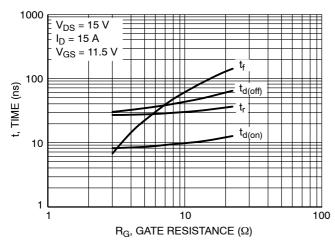


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

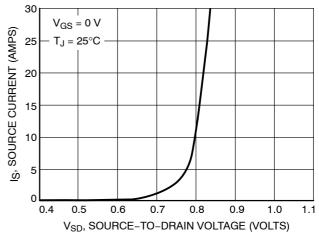


Figure 10. Diode Forward Voltage vs. Current

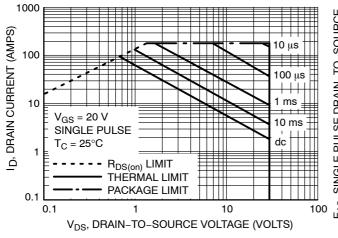


Figure 11. Maximum Rated Forward Biased Safe Operating Area

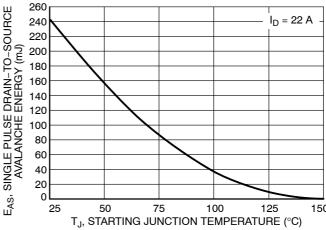


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

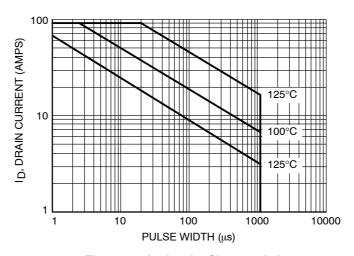


Figure 13. Avalanche Characteristics



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е	1.27 BSC				
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
M	3.00	3.40	3.80		
θ	0 °		12 °		

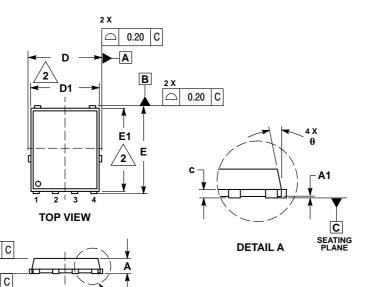
GENERIC MARKING DIAGRAM*

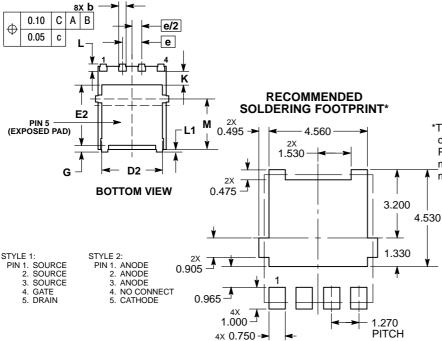


XXXXXX = Specific Device Code
A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DIMENSIONS: MILLIMETERS

DOCUMENT NUMBER:	98AON14036D	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. **onsemi** owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of **onsemi**'s product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf, **onsemi** reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and **onsemi** makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems. or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that onsemi was negligent regarding the design or manufacture of the part. onsemi is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com **TECHNICAL SUPPORT** North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

onsemi Website: www.onsemi.com